PATENT APPLICATION DOCKET NO.: 3239.1000-017

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Raanan A. Miller and Markus Zahn

Application No.:

10/082,803

Group Art Unit:

2881

Filed:

February 21, 2002

Examiner: Gurzo, Paul M.

Confirmation No.:

4435

Title:

LONGITUDINAL FIELD DRIVEN ION MOBILITY FILTER AND

DETECTION SYSTEM

CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as First Class Mail in an envelope addressed to Commissioner for Patents, P.O. Box 1450, Alexandria, VA

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SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Typed or printed name of person signing certificate

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

This Supplemental Information Disclosure Statement is submitted:

under 37 CFR 1.129(a), or

(First/Second submission after Final Rejection)

under 37 CFR 1.97(b), or

> (Within any one of the following time periods: three months of filing national application (other than a CPA) or date of entry of the national stage in an international application; or before the mailing date of a first office action on the merits in a non-provisional application, including a CPA, or a Request for Continued Examination).

[X]

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under 37 CFR 1.97(c) together with either:

[] a Statement under 37 CFR 1.97(e), as checked below, or

[X] a \$180.00 fee under 37 CFR 1.17(p), or
(After the 37 CFR 1.97(b) time period, but before final action or notice of allowance, whichever occurs first)

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[] a Statement under 37 CFR 1.97(e), as checked below, and
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(Filed after final action or notice of allowance, whichever occurs first, but on or before payment of the issue fee)

under 37 CFR 1.97(i):
Applicant requests that the IDS and cited reference(s) be placed in the application filewrapper.
(Filed after payment of issue fee) (Filed after payment of issue fee)

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<u>State</u>	ment Ur	ider 37 (CFR 1.97(e)			
[]	any co	ommuni	information contained in this Information Disclosure Statement was first cited in cation from a foreign patent office in a counterpart foreign application not more on the filing of this Information Disclosure Statement; or			
[]	comm know in the	unication ledge of information	formation contained in this Information Disclosure Statement was cited in a confrom a foreign patent office in a counterpart foreign application, and, to the the undersigned, after making reasonable inquiry, no item of information contained ation disclosure statement was known to any individual designated in 37 CFR than three months prior to the filing of this Information Disclosure Statement.			
<u>State</u>	ment <u>Un</u>	ider 37 (CFR 1.704(d) (Patent Term Adjustment) Applies to original applications (other than design) filed on or after May 29, 2000			
[·]	comm was n	unication of receiver	information contained in the Information Disclosure Statement was cited in a on from a foreign patent office in a counterpart application and this communication wed by any individual designated in § 1.56(c) more than thirty days prior to the information Disclosure Statement.			
[X]	Enclo	Enclosed herewith is form PTO-1449:				
	[X]	Copie	s of the cited references are enclosed.			
	[]	Applie	s of cited references are enclosed except those entered in prior application, U.S. cation No. [], to which priority under 35 U.S.C. 120 is claimed. The earlier ation contains copies of the cited references.			
	[]	The list	sted references were cited in the enclosed International Search Report in a erpart foreign application.			
	[X]	The "o	concise explanation" requirement (non-English references) for references AM2, AO2, AP2, AQ2, AL3 under 37 CFR 1.98(a)(3) are satisfied by:			
		[]	the explanation provided on the attached sheet.			
		[]	the explanation provided in the Specification.			
		[]	submission of the enclosed International Search Report.			
		[.]	submission of the enclosed English-language version of a foreign Search Report and/or foreign Office Action.			
		[X]	the enclosed English language abstract attached to each reference.			

[]	Ap	plic	ant requests that the following r	non-published pending appli	cations be considered:
Examiner's Initials	i				
			U.S. Patent Application No. [], by [inventor(s)], filed [], Docket No.: []
			U.S. Patent Application No. [], by [inventor(s)], filed [], Docket No.: []
			U.S. Patent Application No. [], by [inventor(s)], filed [], Docket No.: []
			Examiner	Date	_
	[]]	A copy of each above-cited app	plication, including the curre	nt claims, is enclosed.
	[]]	A copy of each above-cited app those entered in prior application 35 U.S.C. 120 is claimed.	plication, including the curre on, U.S. Application No. [nt claims, is enclosed, excep], to which priority under
The E	xam:	iner we	r is requested to return a copy of re considered with the next office	the above list of pending ap ce communication.	plications indicating which
It is re	ques	sted	that the information disclosed h	nerein be made of record in t	his application.
Metho	d of	pay	yment:		
[x]			ck for the fee noted above is enc panying Reply. A copy of this S		cluded in the check with the
[]		ase clos	charge Deposit Account 08-038 ed.	30 in the amount of \$[]. A copy of this Statement is
[X]	Ple	ase	charge any deficiency in fees ar	nd credit any overpayment to	Deposit Account 08-0380.
			I	Respectfully submitted,	
				David J. Thibodeau, Jr. Registration No.: 31,671 Telephone: (978) 341-0036 Facsimile: (978) 341-0136	<u> </u>

Concord, MA 01742-9133 Dated: ///6/04/

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ATTORNEY DOCKET NO. 3239.1000-017		LICATION NO. 082,803	
FIRST NAMED INVENTOR Raanan A. Miller		FILING DATE February 21	, 2002
EXAMINER Paul M. Gurzo	CONFI 4435	RMATION NO.	GROUP 2881

U.S. PATENT DOCUMENTS				
EXAM- INER INI- TIAL	REF. NO.	DOCUMENT NUMBER Number-Kind Code (if known)	ISSUE DATE / PUBLICATION DATE MM-DD-YYYY	NAME OF PATENTEE OR APPLICANT OF CITED DOCUMENT
	AD4	3,931,589	01/06/1976	Aisenberg, et al.
	AE4	4,025,818	05/24/1977	Giguere, et al.
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ATTORNEY DOCKET NO.
3239.1000-017

FIRST NAMED INVENTOR
Raanan A. Miller

EXAMINER

APPLICATION NO.
10/082,803

FILING DATE
February 21, 2002

CONFIRMATION NO.
GROUP

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			FOREIGN PATENT D	OCUMENTS			
•		DOCUMENT NUMBER Country Code-Number-Kind Code (if known) DATE MM-DD-YYYY NAME OF PATENTEE OR APPLICANT OF CITED DOCUMENT TRANSLATION YES NO					
	AO	WO 00/08454	02/17/2000	National Research Council Canada			
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Paul M. Gurzo

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ATTORNEY DOCKET NO. APPLICATION NO. 3239.1000-017 10/082,803

FIRST NAMED INVENTOR
Raanan A. Miller

FILING DATE February 21, 2002

EXAMINER
Paul M. Gurzo

CONFIRMATION NO. 4435

GROUP 2881

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	AV	Buryakov, et al., "Drift Spectrometer for the Control of Amine Traces in the Atmosphere," J. Anal. Chem. 48(1):112-121 (1993).
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(Use several sheets if necessary)	EXAMINER Paul M. Gurzo	CONFIR 4435	MATION NO.	GROUP 2881

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